


<b>Search Notes</b>  	<b>Application/Control No.</b>  10560669	<b>Applicant(s)/Patent Under Reexamination</b>  COUTRE, STEVEN
	<b>Examiner</b>  SAMIRA JEAN-LOUIS	<b>Art Unit</b>  1617

SEARCHED			
Class	Subclass	Date	Examiner
None			

SEARCH NOTES		
Search Notes	Date	Examiner
East (U.S. Pat. Full, Derwent, USOCR)-see enclosed search history	11/4/2008	SJL
PubMed- see enclosed search notes	11/4/2008	SJL
PubMed-see enclosed search notes	5/5/2009	SJL
East-see enclosed search notes	5/6/2009	SJL
STN-see enclosed search history	5/6/2009	SJL
East (U.S. Pat. Full, USOCR, PgPub)-see enclosed search notes	12/9/2009	SJL
STIC search-see enclosed search notes	5/8/2009	SJL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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